

FORM PTO 1449 (modified)

U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)  
(Use several sheets if necessary)

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APPLICANT  
Hidenobu HAMADAFILING DATE  
November 19, 2003

GROUP

2883

## U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
BMT	AD	63-33707	2/1988	JP	385	14X	
BMT	AE	2-244105	9/1990	JP	385	14X	
BMT	AF	2002-286952	10/2002	JP	385	14X	
BMT	AG	95/12828	5/1995	WO	385	14X	Abstract
BMT	AH	8-201648	8/1996	JP	385	14X	
BMT	AI	11-109149	4/1999	JP	385	14X	Abstract
	AJ						

## OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

BMT	AK	F. Rottmann, A. Neyer, W. Mevenkamp, and E. Voges, "Integrated-Optic Wavelength Multiplexers on Lithium Niobate Based on Two-Mode Interference", Journal of Lightwave Technology, Vol. 6, No. 6, June 1988, pp. 946-953
BMT	AL	M. R. Paiam, C. F. Janz, R. I. MacDonald, J. N. Broughton, "Compact Planar 980/1550-nm Wavelength Multi-Demultiplexer Based on Multimode Interference", IEEE Photonics Technology Letters, Vol. 7, No. 10, October 1995, pp. 1180-1183
BMT	AM	K. C. Lin and W. Y. Lee, "Guided-wave 1.3/1.55 $\mu$ m wavelength division multiplexer based on multimode interference", IEEE Electronics Letters, Vol. 32, No. 14, July 1996, pp. 1259-1261
BMT	AN	Baojun Li, Guozheng Li, Enke Liu, Zuimin Jiang, Jie Qin, and Xun Wang, "Low-Loss 1 x 2 Multimode Interference Wavelength Demultiplexer in Silicon-Germanium Alloy", IEEE Photonics Technology Letters, Vol. 11, No. 5, May 1999, pp. 575-577
	AO	
EXAMINER	B. Healy	
DATE CONSIDERED	9/13/05	

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include cop. this form with next communication to applicant.